



# SDU/D01N60A

SamHop Microelectronics Corp.

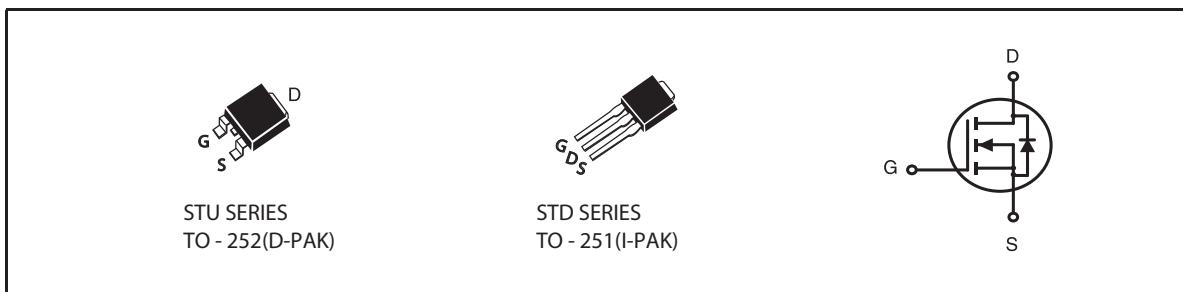
Preliminary

## 600V N-Channel Planar MOSFET

PRODUCT SUMMARY		
V <sub>DSS</sub>	I <sub>D</sub>	R <sub>D(S)</sub> (ON) (mΩ) Max
600V	1.1A	9.3 @ V <sub>G</sub> S=10V, I <sub>D</sub> =0.55A

### FEATURES

- Low Crss (typical 2pF).
- Fast Switching.
- 100% Avalanche Rated.



### ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Max.	Units
V <sub>DSS</sub>	Drain-Source Voltage	600	V
V <sub>GS</sub>	Gate-Source Voltage	±30	V
I <sub>D</sub>	Continuous Drain Current T <sub>C</sub> =25°C	1.1	A
		0.7	A
I <sub>DM</sub>	Pulsed Drain Current, V <sub>G</sub> S=10V <sup>a</sup>	4.4	A
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>b</sup>	36	mJ
dv/dt	Peak Diode Recovery Energy <sup>c</sup>	4.5	V/ns
P <sub>D</sub>	Power Dissipation T <sub>C</sub> =25°C	26	W
	Linear Derating Factor T <sub>C</sub> >25°C	10.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150	°C

### THERMAL CHARACTERISTICS

R <sub>θ</sub> JC	Thermal Resistance, Junction-to-Case	4.8	°C/W
R <sub>θ</sub> JA	Thermal Resistance, Junction-to-Ambient	50	°C/W

Details are subject to change without notice.

Jul,22,2009

# SDU/D01N60A

Preliminary

## ELECTRICAL CHARACTERISTICS ( $T_A=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>OFF CHARACTERISTICS</b>						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	600			V
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ C$ , $I_D=250\mu A$		0.6		$V/^\circ C$
$I_{DSS}$	Drain-to-Source Leakage Current	$V_{DS}=600V, V_{GS}=0V$			20	$\mu A$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{DS}=0V, V_{GS}=30V$			100	nA
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{DS}=0V, V_{GS}=-30V$			-100	nA
<b>ON CHARACTERISTICS</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0		4.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=0.55A^d$			9.3	ohm
$g_{FS}$	Forward Transconductance	$V_{DS}=15V, I_D=0.55A^d$			10	S
<b>DYNAMIC CHARACTERISTICS</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=25V, V_{GS}=0V$ $f=1.0MHz$		169		pF
$C_{oss}$	Output Capacitance			25		pF
$C_{rss}$	Reverse Transfer Capacitance			2		pF
<b>SWITCHING CHARACTERISTICS</b>						
$t_{D(on)}$	Turn-On Delay Time	$V_{DD}=300V$ $I_D=1.1A$ $R_G=10\text{ ohm}, R_D=300\text{ ohm}$ $V_{GS}=10V^d$		9.1		ns
$t_r$	Turn-On Rise Time			27		ns
$t_{D(off)}$	Turn-Off Delay Time			17		ns
$t_f$	Turn-Off Fall Time			35		ns
$Q_g$	Total Gate Charge	$V_{DS}=300V, I_D=1.1A$ $V_{GS}=10V^d$		6.2		nC
$Q_{gs}$	Gate-Source Charge			0.9		nC
$Q_{gd}$	Gate-Drain("Miller") Charge			3.5		nC
<b>DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS</b>						
$I_s$	Maximum Continuous Source Current(Body Diode)			1.1		A
$I_{SM}$	Maximum Pulsed Source Current(Body Diode)			4.4		A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS}=0V, I_s=0.55A^d$			1.5	V
<b>Notes :</b>						
a. Repetitive Rating : Pulse width limited by maximum junction temperature.						
b. $V_{DD}=50V$ , starting $T_J=25^\circ C, L=72mH, R_G=25\Omega, I_{AS}=1A$						
c. $I_{SD} \leq 1A, di/dt \leq 100A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ C$						
d. Pulse Test : Pulse width $\leq 300\mu s$ , Duty cycle $\leq 2\%$ .						

Jul,22,2009

# SDU/D01N60A

Preliminary

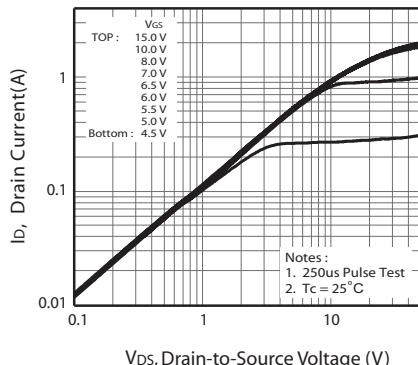


Figure 1. Output Characteristics

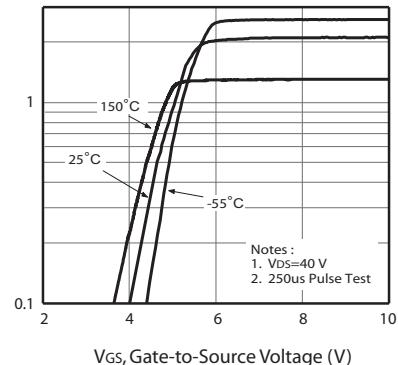


Figure 2. Transfer Characteristics

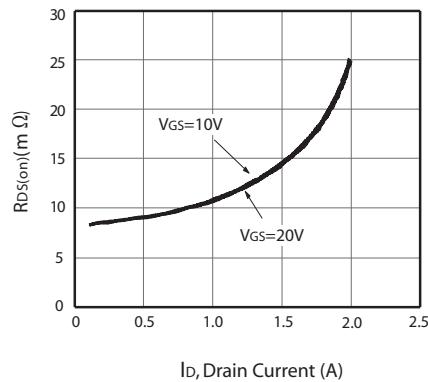


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

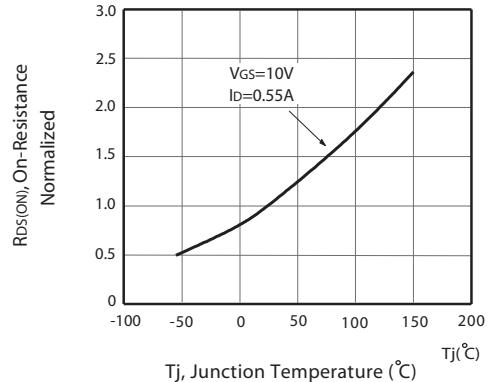


Figure 4. On-Resistance Variation with Drain Current and Temperature

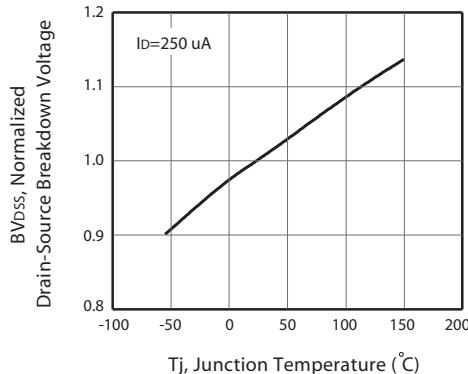


Figure 5. Breakdown Voltage Variation with Temperature

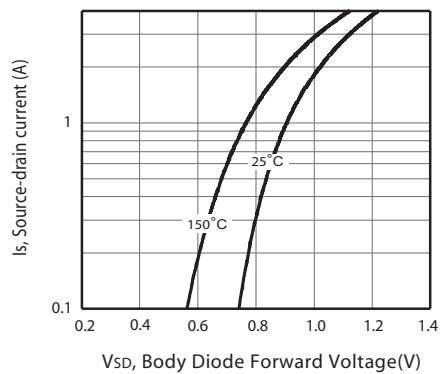


Figure 6. Body Diode Forward Voltage Variation with Source Current

Jul,22,2009

# SDU/D01N60A

Preliminary

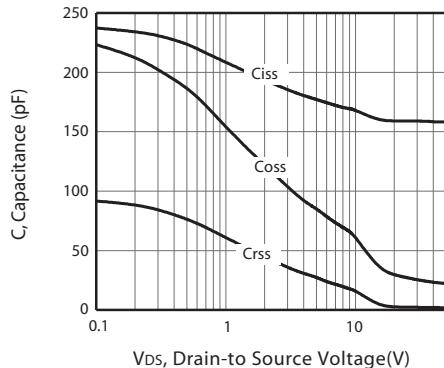


Figure 7. Capacitance

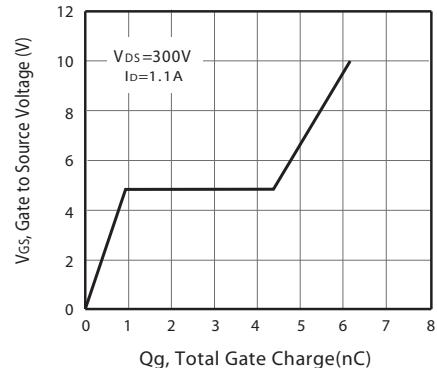


Figure 8. Gate Charge

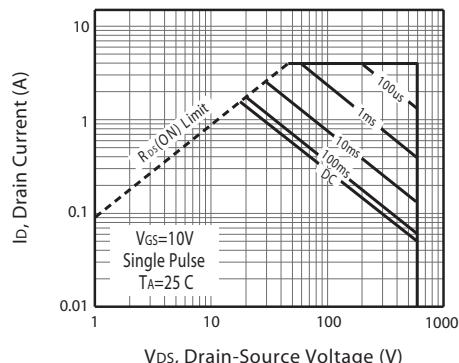
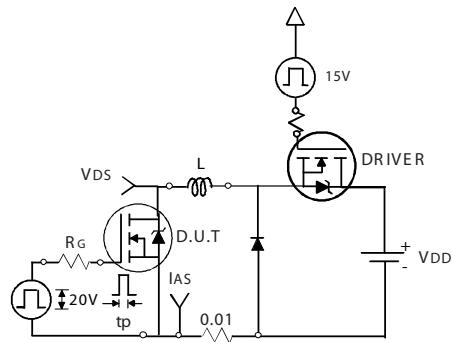


Figure 9. Maximum Safe Operating Area

Jul,22,2009

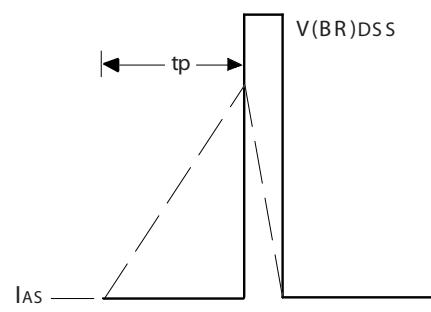
# SDU/D01N60A

Preliminary



Unclamped Inductive Test Circuit

Figure 10a.



Unclamped Inductive Waveforms

Figure 10b.

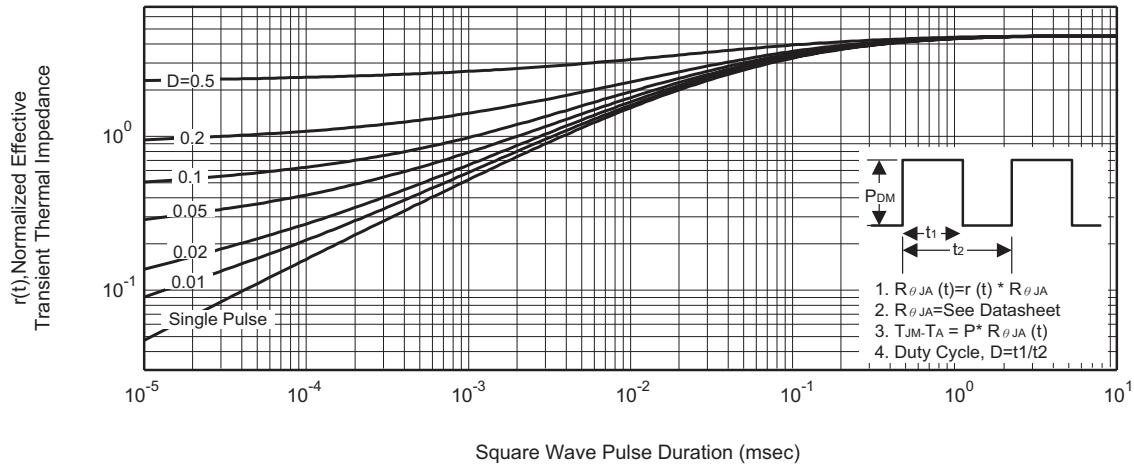


Figure 11. Normalized Thermal Transient Impedance Curve

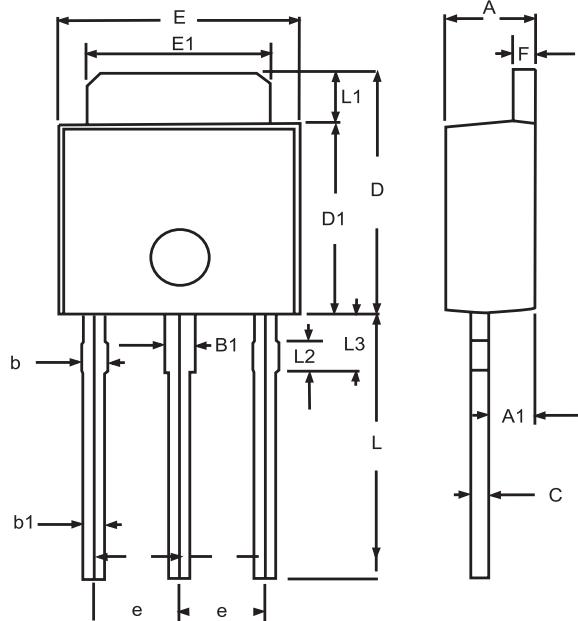
Jul,22,2009

# SDU/D01N60A

Preliminary

## PACKAGE OUTLINE DIMENSIONS

TO-251

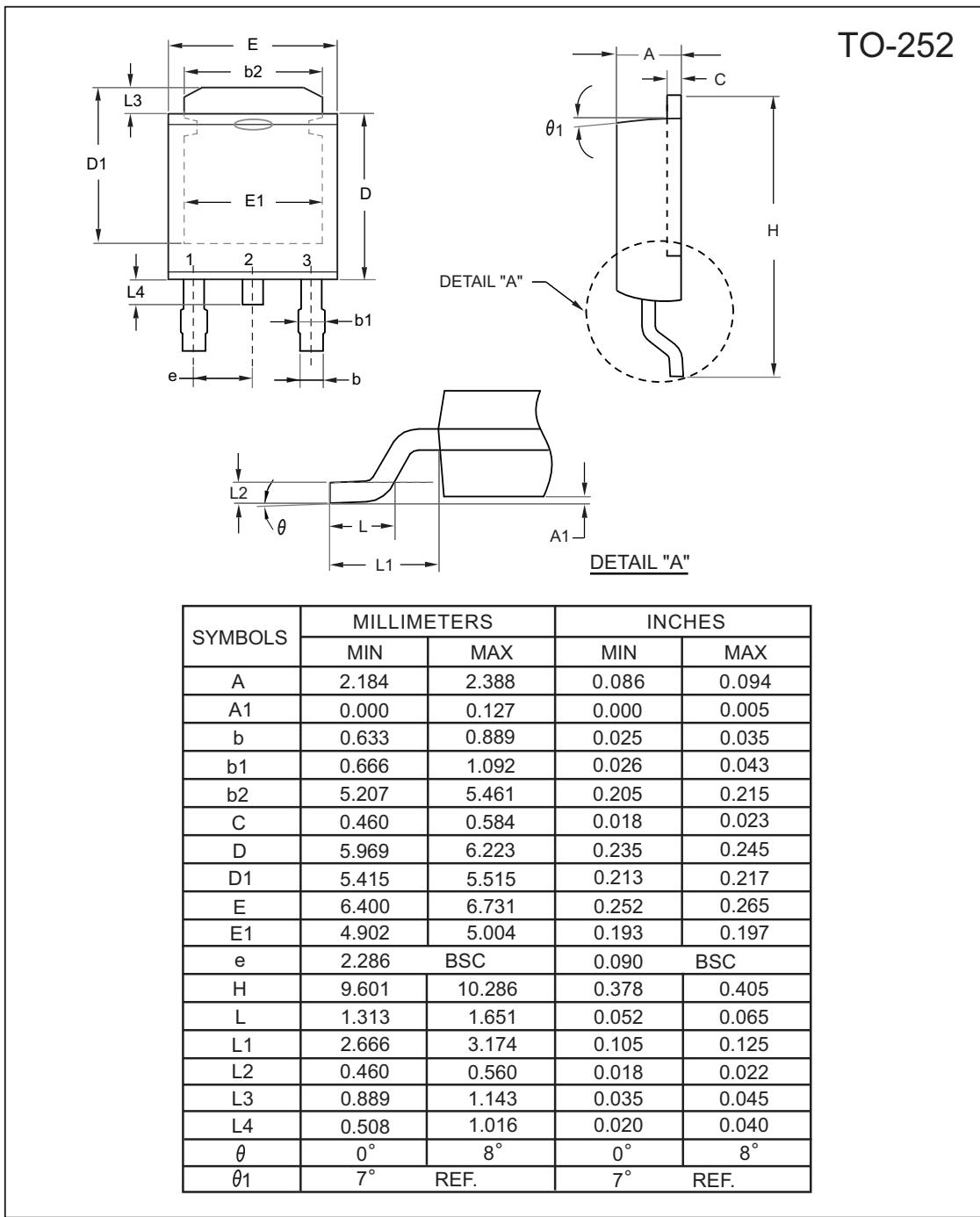


SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.20	2.40	0.087	0.095
A1	1.100	1.300	0.043	0.051
B1	0.650	1.050	0.026	0.041
b	0.500	0.900	0.020	0.035
b1	0.400	0.800	0.016	0.32
C	0.400	0.600	0.016	0.024
D	6.700	7.300	0.264	0.287
D1	5.400	5.650	0.213	0.222
E	6.40	6.650	0.252	0.262
e	2.100	2.500	0.083	0.098
F	0.400	0.600	0.016	0.024
L	7.000	8.000	0.276	0.315
L1	1.300	1.700	0.051	0.067
L2	0.700	0.900	0.028	0.035
L3	1.400	1.800	0.055	0.071

Jul,22,2009

# SDU/D01N60A

Preliminary



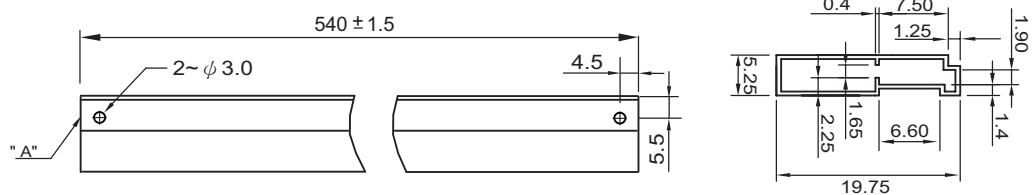
Jul,22,2009

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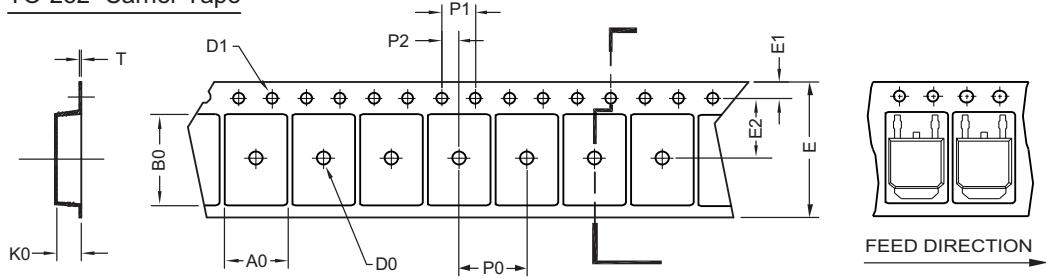
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## TO-251 Tube/TO-252 Tape and Reel Data

### TO-251 Tube



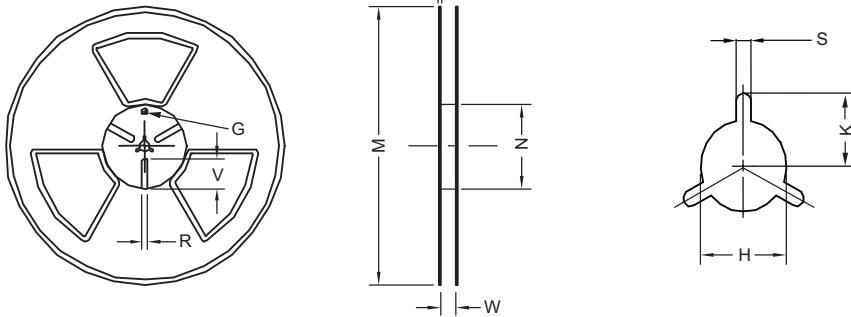
### TO-252 Carrier Tape



UNIT:mm

PACKAGE	A0	B0	K0	D0	D1	E	E1	E2	P0	P1	P2	T
TO-252 (16 mm)	6.96 ±0.1	10.49 ±0.1	2.79 ±0.1	ψ 2	ψ 1.5 +0.1 - 0	16.0 ±0.3	1.75 ±0.1	7.5 ±0.15	8.0 ±0.1	4.0 ±0.1	2.0 ±0.15	0.3 ±0.05

### TO-252 Reel



UNIT:mm

TAPE SIZE	REEL SIZE	M	N	W	T	H	K	S	G	R	V
16 mm	ψ 330	ψ 330 ± 0.5	ψ 97 ± 1.0	17.0 + 1.5 - 0	2.2	ψ 13.0 + 0.5 - 0.2	10.6	2.0 ± 0.5	---	---	---

Jul,22,2009